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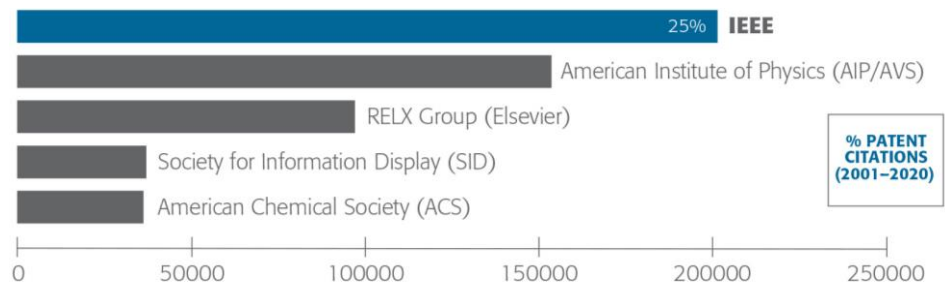
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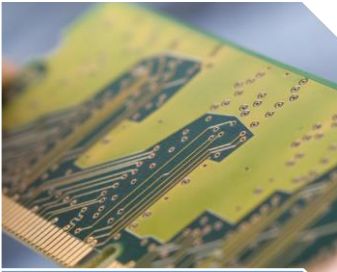
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- IEEE International Conference on Semiconductor Electronics
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- IEEE/SEMI Conference and Workshop Advanced Semiconductor Manufacturing
- International Conference on Advanced Semiconductor Devices and Microsystems
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- | | |
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| 592-2007 | IEEE Standard for Exposed Semiconducting Shields on High-Voltage Cable Joints and Separable Connectors |
| 1450.1-2005 | IEEE Standard for Extensions to Standard Test Interface Language (STIL) (IEEE Std 1450 /SUP TM/ 1999) for Semiconductor Design Environments |
| IEC 62526 edition 1.0 2007 | Standard for Extensions to Standard Test Interface Language (STIL) for Semiconductor Design Environments |
| C57.18.10-1998 | IEEE Standard Practices and Requirements for Semiconductor Power Rectifier Transformers |
| C62.35-2010 | IEEE Standard Test Methods for Avalanche Junction Semiconductor Surge-Protective Device Components |
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